

# **LITIX™ Basic**

#### **TLD1125EL**

**1 Channel High-Side Current Source** 



<span id="page-0-0"></span>**1 Overview**

#### **Applications**

- Exterior LED lighting applications such as tail/brake light, turn indicator, position light, side marker,...
- Interior LED lighting applications such as ambient lighting, interior illumination and dash board lighting.







**Application Diagram with TLD1125EL**

#### **Overview**



#### **Basic Features**

- 1 Channel device with integrated output stage (current source), optimized to drive LEDs with output current up to 360 mA
- Low current consumption in sleep mode
- PWM-operation supported via VS- and EN-pin
- Integrated PWM dimming engine to provide two LED brightness levels without external logic (e.g. µC)
- Output current adjustable via external low power resistor and possibility to connect PTC resistor for LED protection during over temperature conditions
- Reverse polarity protection and overload protection
- Undervoltage detection
- Open load and short circuit to GND diagnosis
- Wide temperature range:  $-40^{\circ}C < T_i < 150^{\circ}C$
- PG-SSOP-14 package with exposed heatslug

#### **Description**

The LITIX™ Basic TLD1125EL is a one channel high side driver IC with integrated output stage. It is designed to control LEDs with a current up to 360 mA. In typical automotive applications the device is capable to drive i.e. 3 red LEDs with a current up to 180 mA, which is limited by thermal cooling aspects. The output current is controlled practically independent of load and supply voltage changes.



#### **Table 1 Product Summary**

#### **Protective Functions**

- **•** ESD protection
- Under voltage lock out
- Over Load protection
- Over Temperature protection
- **•** Reverse Polarity protection

#### **Diagnostic Functions**

- OL detection
- SC to Vs (indicated by OL diagnosis)
- SC to GND detection



**Block Diagram**

## <span id="page-2-0"></span>**2 Block Diagram**



**Figure 1 Basic Block Diagram**



**Pin Configuration**

# <span id="page-3-0"></span>**3 Pin Configuration**

### <span id="page-3-1"></span>**3.1 Pin Assignment**



**Figure 2 Pin Configuration**

### **Pin Configuration**

## <span id="page-4-1"></span>**3.2 Pin Definitions and Functions**

<span id="page-4-0"></span>

**General Product Characteristics**



## <span id="page-5-1"></span>**4 General Product Characteristics**

#### <span id="page-5-2"></span>**4.1 Absolute Maximum Ratings**

#### **Absolute Maximum Ratings 1)**

 $T_j$  = -40°C to +150°C; all voltages with respect to ground, positive current flowing into pin for input pins (I), positive currents flowing out of the I/O and output pins (O) (unless otherwise specified)



1) Not subject to production test, specified by design

2) ESD susceptibility, Human Body Model "HBM" according to ANSI/ESDA/JEDEC JS-001-2011

<span id="page-5-0"></span>3) ESD susceptibility, Charged Device Model "CDM" according to JESD22-C101E

*Note: Stresses above the ones listed here may cause permanent damage to the device. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.*

*Note: Integrated protection functions are designed to prevent IC destruction under fault conditions described in the data sheet. Fault conditions are considered as "outside" normal operating range. Protection functions are not designed for continuous repetitive operation.*



#### **General Product Characteristics**

#### <span id="page-6-3"></span>**4.2 Functional Range**



*Note: Within the functional range the IC operates as described in the circuit description. The electrical characteristics are specified within the conditions given in the related electrical characteristics table.*

#### <span id="page-6-4"></span>**4.3 Thermal Resistance**

<span id="page-6-1"></span>

<span id="page-6-2"></span><span id="page-6-0"></span>1) Not subject to production test, specified by design. Based on simulation results.

2) Specified  $R_{th,C}$  value is simulated at natural convection on a cold plate setup (all pins and the exposed Pad are fixed to ambient temperature).  $T<sub>a</sub> = 85^{\circ}$ C, Total power dissipation 1.5 W.

- 3) The  $R_{th|A}$  values are according to Jedec JESD51-3 at natural convection on 1s0p FR4 board. The product (chip + package) was simulated on a 76.2 x 114.3 x 1.5 mm<sup>3</sup> board with 70 µm Cu, 300 mm<sup>2</sup> cooling area. Total power dissipation 1.5 W distributed statically and homogenously over power stage.
- 4) The  $R_{\text{th}}$  values are according to Jedec JESD51-5,-7 at natural convection on 2s2p FR4 board. The product (chip + package) was simulated on a 76.2 x 114.3 x 1.5 mm<sup>3</sup> board with 2 inner copper layers (outside 2 x 70  $\mu$ m Cu, inner 2 x 35  $\mu$ m Cu). Where applicable, a thermal via array under the exposed pad contacted the first inner copper layer. Total power dissipation 1.5 W distributed statically and homogenously over power stage.

#### **EN Pin**



### <span id="page-7-1"></span>**5 EN Pin**

The EN pin is a dual function pin:



#### **Figure 3 Block Diagram EN pin**

*Note: The current consumption at the EN-pin I<sub>EN</sub> needs to be added to the total device current consumption. The total current consumption is the sum of the currents at the VS-pin I<sub>s</sub> and the EN-pin I<sub>EN</sub>.* 

#### <span id="page-7-2"></span>**5.1 EN Function**

If the voltage at the pin EN is below a threshold of *V*<sub>EN(off)</sub> the LITIX™ Basic IC will enter Sleep mode. In this state all internal functions are switched off, the current consumption is reduced to *I*<sub>S(sleep)</sub>. A voltage above  $V_{EN(on)}$  at this pin enables the device after the Power on reset time  $t_{\text{POR}}$ .



#### <span id="page-7-0"></span>**Figure 4 Power on reset**

#### **EN Pin**

<span id="page-8-0"></span>

The EN pin can be used to supply the internal logic. There are two typical application conditions, where this feature can be used:

1) In "DC/DC control Buck" configurations, where the voltage  $V_s$  can be below 5.5V.

2) In configurations, where a PWM signal is applied at the Vbatt pin of a light module. The buffer capacitor C<sub>BUF</sub> is used to supply the LITIX<sup>™</sup> Basic IC during Vbatt low (*V<sub>s</sub>* low) periods. This feature can be used to minimize the turn-on time to the values specified in **[Pos. 11.2.15](#page-30-0)**. Otherwise, the power-on reset delay time  $t_{\text{pOR}}$ (**[Pos. 6.3.8](#page-14-0)**) has to be considered.

The capacitor can be calculated using the following formula:

$$
C_{\text{BUF}} = t_{\text{LOW(max)}} \cdot \frac{I_{\text{EN(LS)}}}{V_{\text{S}} - V_{\text{D1}} - V_{\text{S(POR)}}}
$$

(1)

See also a typical application drawing in **[Chapter 12](#page-31-0)**.



Figure 5 External circuit when applying a fast PWM signal on  $V_{\text{BAT}}$ 





#### **EN Pin**



<span id="page-9-1"></span>**Figure 6** Typical waveforms when applying a fast PWM signal on  $V_{\text{BATT}}$ 

The parameter  $t_{ON(VS)}$  is defined at **[Pos. 11.2.15](#page-30-0)**. The parameter  $t_{OFF(VS)}$  depends on the load and supply voltage  $V_{\text{BAT}}$  characteristics.

#### <span id="page-9-2"></span>**5.3 EN Unused**

In case of an unused EN pin, there are two different ways to connect it:

#### <span id="page-9-0"></span>**5.3.1 EN - Pull Up to VS**

The EN pin can be connected with a pull up resistor (e.g. 10 kΩ) to *V*<sub>s</sub> potential. In this configuration the LITIX™ Basic IC is always enabled.

#### <span id="page-9-3"></span>**5.3.2 EN - Direct Connection to VS**

The EN pin can be connected directly to the VS pin (IC always enabled). This configuration has the advantage (compared to the configuration described in **[Chapter 5.3.1](#page-9-0)**) that no additional external component is required.



#### **PWMI Pin**

### <span id="page-10-1"></span>**6 PWMI Pin**

The PWMI pin is designed as a dual function pin.



#### **Figure 7 Block Diagram PWMI pin**

The pin can be used for PWM-dimming via a push-pull stage of a micro controller, which is connecting the PWMI-pin to a low or high potential.

*Note: The micro controller's push-pull stage has to able to sink currents according to [Pos. 6.3.18](#page-15-0) to activate the device.*

Furthermore, the device offers also an internal PWM unit by connecting an external-RC network according to **[Figure 10](#page-12-0)**.

### <span id="page-10-2"></span>**6.1 PWM Dimming**

A PWM signal can be applied at the PWMI pin for LED brightness regulation. The dimming frequency can be adjusted in a very wide range (e.g. 400 Hz). The PWMI pin is low active. Turn on/off thresholds V<sub>PWMI(1)</sub> and  $V_{\text{pWM}(H)}$  are specified in parameters **[Pos. 6.3.15](#page-15-1)** and **[Pos. 6.3.16](#page-15-2)**.



<span id="page-10-0"></span>**Figure 8 Turn on and Turn off time for PWMI pin usage**



#### **PWMI Pin**

#### <span id="page-11-0"></span>**6.2 Internal PWM Unit**

Connecting a resistor and a capacitor in parallel on the PWMI pin enables the internal pulse width modulation unit. The following figure shows the charging and discharging defined by the RC-network according to **[Figure 10](#page-12-0)** and the internal PWM unit.



**Figure 9 PWMI operating voltages**

The PWM Duty cycle (DC) and the PWM frequency can be adjusted using the formulas below. Please use only typical values of  $V_{\text{PWMI(L)}}$ ,  $V_{\text{PWMI(H)}}$  and  $I_{\text{PWMI(on)}}$  for the calculation of  $t_{\text{PWMI(on)}}$  and  $t_{\text{PWMI(off)}}$  (as described in **[Pos. 6.3.15](#page-15-1)** to **[Pos. 6.3.18](#page-15-0)**).

$$
t_{\text{PWMI(on)}} = -R_{\text{PWMI}} \cdot C_{\text{PWMI}} \cdot \text{LN}\left(\frac{V_{\text{PWMI(H)}} - I_{\text{PWMI(on)}} \cdot R_{\text{PWMI}}}{V_{\text{PWMI(L)}} - I_{\text{PWMI(on)}} \cdot R_{\text{PWMI}}}\right)
$$
\n(2)

$$
t_{\text{PWM1(off)}} = R_{\text{PWM1}} \cdot C_{\text{PWM1}} \cdot \text{LN}\left(\frac{V_{\text{PWM1(H)}}}{V_{\text{PWM1(L)}}}\right)
$$
(3)

$$
f_{\rm{PWMI}} = \frac{1}{t_{\rm{PWMI(on)} } + t_{\rm{PWMI(off)}}}
$$
(4)

$$
DC = t_{\text{PWMI(on)}} \cdot f_{\text{PWMI}} \tag{5}
$$

Out of this equations the required C<sub>PWMI</sub> and R<sub>PWMI</sub> can be calculated:

$$
-I_{\text{PWMI(on)}} \cdot t_{\text{PWMI(off)}} \cdot \left[ \frac{V_{\text{PWMI(L)}}}{V_{\text{PWMI(H)}}} \right] \frac{t_{\text{PWMI(on)}}}{t_{\text{PWMI(H)}}}
$$
\n
$$
C_{\text{PWMI}} = \frac{L_{\text{PWMI(on)}} \left[ V_{\text{PWMI(L)}} \right] \left[ V_{\text{PWMI(L)}} \right] \left[ V_{\text{PWMI(L)}} \right] \left[ V_{\text{PWMI(H)}} \right] \left[ V_{\text{PWMI(H)}} \right] \left[ V_{\text{PWMI(H)}} \right]
$$
\n
$$
R_{\text{PWMI}} = \frac{t_{\text{PWMI(off)}}}{C_{\text{PWMI}} \cdot L N \left( \frac{V_{\text{PWMI(L)}}}{V_{\text{PWMI(L)}}} \right)} \tag{7}
$$



#### **PWMI Pin**

#### See **[Figure 10](#page-12-0)** for a typical external circuitry.

*Note: In case of junction temperatures above T*<sub>j(CRT)</sub> ([Pos. 11.2.16](#page-30-1)) the device provides a temperature dependent *current reduction feature as descirbed in [Chapter 11.1.1](#page-28-0).* In case of output current reduction I<sub>IN\_SET</sub> is *reduced as well, which leads to increased turn on-times t<sub>PWMI(on)</sub>, because the C<sub>PWMI</sub> is charged slower. The*  $turn$  off-time  $t_{\text{PWMI(off)}}$  remains the same.



<span id="page-12-0"></span>**Figure 10 Typical circuit using internal PWM unit**



#### **PWMI Pin**

## <span id="page-13-1"></span>**6.3 Electrical Characteristics Internal Supply / EN / PWMI Pin**

#### **Electrical Characteristics Internal Supply / EN / PWMI pin**

Unless otherwise specified: *V*<sub>S</sub> = 5.5 V to 40 V, *T*<sub>j</sub> = -40°C to +150°C, *R*<sub>SET</sub> = 12 kΩ all voltages with respect to ground, positive current flowing into pin for input pins (I), positive currents flowing out of the I/O and output pins (O) (unless otherwise specified)

<span id="page-13-0"></span>



#### **PWMI Pin**

#### **Electrical Characteristics Internal Supply / EN / PWMI pin** (cont'd)

Unless otherwise specified: *V*<sub>S</sub> = 5.5 V to 40 V, *T*<sub>j</sub> = -40°C to +150°C, *R*<sub>SET</sub> = 12 kΩ all voltages with respect to ground, positive current flowing into pin for input pins (I), positive currents flowing out of the I/O and output pins (O) (unless otherwise specified)

<span id="page-14-3"></span><span id="page-14-2"></span><span id="page-14-1"></span><span id="page-14-0"></span>

#### **PWMI Pin**

#### **Electrical Characteristics Internal Supply / EN / PWMI pin** (cont'd)

Unless otherwise specified: *V*<sub>S</sub> = 5.5 V to 40 V, *T*<sub>j</sub> = -40°C to +150°C, *R*<sub>SET</sub> = 12 kΩ all voltages with respect to ground, positive current flowing into pin for input pins (I), positive currents flowing out of the I/O and output pins (O) (unless otherwise specified)

<span id="page-15-2"></span><span id="page-15-1"></span>

<span id="page-15-3"></span><span id="page-15-0"></span>1) Not subject to production test, specified by design

<span id="page-15-4"></span>2) The total device current consumption is the sum of the currents  $I_S$  and  $I_{EN(H)}$ , please refer to **[Pos. 6.3.14](#page-14-1)** 

3) See also **[Figure 4](#page-7-0)**

<span id="page-15-6"></span>4) Parameter valid if an external PWM signal is applied

<span id="page-15-5"></span>5) If TTL level compatibility is required, use  $\mu$ C open drain output with pull up resistor



#### **IN\_SET Pin**

### <span id="page-16-1"></span>**7 IN\_SET Pin**

The IN\_SET pin is a multiple function pin for output current definition, input and diagnostics:



**Figure 11 Block Diagram IN\_SET pin**

### <span id="page-16-2"></span>**7.1 Output Current Adjustment via RSET**

The current adjustment can be done by placing a low power resistor  $(R_{\text{SET}})$  at the IN\_SET pin to ground. The dimensioning of the resistor can be done using the formula below:

$$
R_{\rm SET} = \frac{k}{I_{\rm OUT}} \tag{8}
$$

The gain factor *k* ( $R_{\text{SET}}$ <sup>\*</sup> output current) is specified in **[Pos. 11.2.4](#page-29-0)** and **[Pos. 11.2.5](#page-29-1)**. The current through the  $R_{\text{SET}}$  is defined by the resistor itself and the reference voltage  $V_{\text{IN}}$  s<sub>ET(ref)</sub>, which is applied to the IN\_SET during supplied device.

### <span id="page-16-0"></span>**7.2 Smart Input Pin**

The IN\_SET pin can be connected via  $R_{\text{SFT}}$  to the open-drain output of a  $\mu$ C or to an external NMOS transistor as described in **[Figure 12](#page-17-0)**. This signal can be used to turn off the output stage of the IC. A minimum IN\_SET current of *I<sub>IN\_SET(act)</sub> is required to turn on the output stage. This feature is implemented to prevent glimming* of LEDs caused by leakage currents on the IN\_SET pin, see **[Figure 15](#page-18-0)** for details. In addition, the IN\_SET pin offers the diagnostic feedback information, if the status pin is connected to GND. Another diagnostic possibility is shown in **[Figure 13](#page-17-1)**, where the diagnosis information is provided via the ST pin (refer to **[Chapter 8](#page-19-0)** and **[Chapter 10](#page-22-0)**) to a micro controller. In case of a fault event with the ST pin connected to GND the IN\_SET voltage is increased to  $V_{IN-SET(OL/SC)}$  **[Pos. 10.3.2](#page-25-0)**. Therefore, the device has two voltage domains at the IN\_SET-pin, which is shown in **[Figure 16](#page-18-1)**.

#### **IN\_SET Pin**





<span id="page-17-0"></span>**Figure 12 Schematics IN\_SET interface to µC, diagnosis via IN\_SET pin**



<span id="page-17-1"></span>**Figure 13 Schematics IN\_SET interface to µC, diagnosis via ST pin**

The resulting switching times are shown in **[Figure 14](#page-17-2)**:



<span id="page-17-2"></span>**Figure 14 Switching times via IN\_SET**



#### **IN\_SET Pin**



<span id="page-18-0"></span>



<span id="page-18-1"></span>**Figure 16 Voltage domains for IN\_SET pin, if ST pin is connected to GND**

#### **ST Pin**



### <span id="page-19-0"></span>**8 ST Pin**

The ST pin is a multiple function pin.



**Figure 17 Block Diagram ST pin**

### <span id="page-19-1"></span>**8.1 Diagnosis Selector**

If the status pin is unconnected or connected to GND via a high ohmic resistor ( $V_{ST}$  to be below  $V_{ST(1)}$ ), the ST pin acts as diagnosis output pin. In normal operation (device is activated) the ST pin is pulled to GND via the internal pull down current *I*<sub>ST(PD)</sub>. In case of an open load or short circuit to GND condition the ST pin is switched to  $V_{ST(OL/SC)}$  after the filter time $t_D$  (see **[Equation \(11\)](#page-24-0)**).

If the device is operated in PWM operation via the VS and/or EN pins the ST pin should be connected to GND via a high ohmic resistor (e.g. 470 kΩ) to ensure proper device behavior during fast rising VS and/or EN slopes. If the ST pin is shorted to GND the diagnostic feedback is performed via the IN\_SET-pin, which is shown in **[Chapter 7.2](#page-16-0)** and **[Chapter 10](#page-22-0)**.

### <span id="page-19-2"></span>**8.2 Diagnosis Output**

If the status pin is unconnected or connected to GND via a high ohmic resistor ( $V_{ST}$  to be below  $V_{ST(L)}$ ), it acts as a diagnostic output. In case of a fault condition the ST pin rises its voltage to  $V_{ST(OL/SC)}$  ([Pos. 10.3.7](#page-26-0)). Details are shown in **[Chapter 10](#page-22-0)**.

#### <span id="page-19-3"></span>**8.3 Disable Input**

If an external voltage higher than  $V_{ST(H)}$  ([Pos. 10.3.5](#page-26-1)) is applied to the ST pin, the device is switched off. This function is used for applications, where multiple drivers should be used for one light function. It is possible to combine the drivers' fault diagnosis via the ST pins. If a single LED chain fails, the entire light function is switched off. In this scenario e.g. the diagnostic circuit on the body control module can easily distinguish between the two cases (normal load or load fault), because nearly no current is flowing into the LED module during the fault scenario - the drivers consume a current of  $I_{S(fault,STu)}$  ([Pos. 6.3.6](#page-14-2)) or  $I_{S(dis,ST)}$  ([Pos. 6.3.3](#page-13-0)).

As soon as one LED chain fails, the ST-pin of this device is switched to  $V_{ST(OL/SC)}$ . The other devices used for the same light function can be connected together via the ST pins. This leads to a switch off of all devices connected together. Application examples are shown in **[Chapter 12](#page-31-0)**.



#### **ST Pin**



<span id="page-20-0"></span>**Figure 18 Switching times via ST Pin**

#### **D Pin**



### <span id="page-21-0"></span>**9 D Pin**

The D pin is designed as a single function pin.



#### **Figure 19 Block Diagram D pin**

The D pin can be used to extend the open load detection filter time  $t_{\sf OL}$  by adding a small signal capacitor to the D pin as shown in **[Figure 26](#page-31-1)**. The filter time  $t_{\sf D}$ , which is defined by the charging current / $_{\sf D}$  (**[Pos. 10.3.10](#page-26-2)**). The time is adjustable according to the following equation:

$$
t_{\rm typ} = \frac{C_{\rm D} \cdot V_{\rm D(th)}}{I_{\rm D}} \tag{9}
$$

**Load Diagnosis**



### <span id="page-22-0"></span>**10 Load Diagnosis**

#### <span id="page-22-1"></span>**10.1 Open Load**

An open load diagnosis feature is integrated in the TLD1125EL driver IC. If there is an open load on the output, the output is turned off. The potential on the IN\_SET pin rises up to  $V_{IN\_SET(OL/SC)}$ . This high voltage can be used as input signal for an µC as shown in **[Figure 13](#page-17-1)**. The open load status is not latched, as soon as the open load condition is no longer present, the output stage will be turned on again. An open load condition is detected, if the voltage drop over the output stage  $V_{PS}$  is below the threshold according **[Pos. 10.3.11](#page-26-3)**. The output is deactivated after a filter time  $t_{\sf D}$ , which is defined by the charging current  $I_{\sf D}$  **[Pos. 10.3.10](#page-26-2)**. The time is adjustable by the capacitor connected to the D pin according the following equation:

$$
t_{\rm D, typ} = \frac{C_{\rm D} \cdot V_{\rm D(th)}}{I_{\rm D}} \tag{10}
$$



**Figure 20 IN\_SET behavior during open load condition with ST pin connected to GND**



**Load Diagnosis**



**Figure 21 IN\_SET and ST behavior during open load condition (ST unconnected)**

To provide a Limp Home functionality (reactivation in case of open load instead of complete deactivation) the filter time  $t_p$  can be used. If a PWM signal with a frequency higher than  $1/t_p$  is applied to the  $V_s$  line and EN signal, the OL detection feature will not be activated. The implementation of the D-pin is shown in the following figure:



**Figure 22 Block Diagram D pin**

#### **Load Diagnosis**



### <span id="page-24-1"></span>**10.2 Short Circuit to GND detection**

The TLD1125EL has an integrated SC to GND detection. If the output stage is turned on and the voltage at the output falls below  $V_{\text{OUT(SC)}}$  the potential on the IN\_SET pin is increased up to  $V_{\text{IN\_SET(OL/SC)}}$  after  $t_{\text{SC}}$  if the ST pin is connected to GND. If the ST is open or connected to GND via a high ohmic resistor the fault is indicated on the ST pin according to **[Chapter 8](#page-19-0)** after  $t<sub>D</sub>$ . More details are shown in [Figure 24](#page-25-1). This condition is not latched. For detecting a normal condition after a short circuit detection an output current according to  $I_{\text{OUT(SC)}}$  is driven by the channel.

The filter time  $t<sub>D</sub>$  is defined by the charging current  $I<sub>D</sub>$  **[Pos. 10.3.10](#page-26-2)**. The time is adjustable by the capacitor connected to the D pin according the following equation:

<span id="page-24-0"></span>
$$
t_{\rm D, typ} = \frac{C_{\rm D} \cdot V_{\rm D(th)}}{I_{\rm D}} \tag{11}
$$



**Figure 23 IN\_SET behavior during short circuit to GND condition with ST connected to GND**



#### **Load Diagnosis**



<span id="page-25-1"></span>

## <span id="page-25-3"></span>**10.3 Electrical Characteristics IN\_SET Pin and Load Diagnosis**

### **Electrical Characteristics IN\_SET pin and Load Diagnosis**

Unless otherwise specified:  $V_s$  = 5.5 V to 40 V,  $T_j$  = -40°C to +150°C,  $R_{\texttt{SET}}$  = 12 kΩ, all voltages with respect to ground, positive current flowing into pin for input pins (I), positive currents flowing out of the I/O and output pins (O) (unless otherwise specified)

<span id="page-25-2"></span><span id="page-25-0"></span>

#### **Load Diagnosis**

#### **Electrical Characteristics IN\_SET pin and Load Diagnosis** (cont'd)

Unless otherwise specified:  $V_s$  = 5.5 V to 40 V,  $T_j$  = -40°C to +150°C,  $R_{\text{SET}}$  = 12 kΩ, all voltages with respect to ground, positive current flowing into pin for input pins (I), positive currents flowing out of the I/O and output pins (O) (unless otherwise specified)

<span id="page-26-3"></span><span id="page-26-2"></span><span id="page-26-1"></span><span id="page-26-0"></span>

#### **Load Diagnosis**

#### **Electrical Characteristics IN\_SET pin and Load Diagnosis** (cont'd)

Unless otherwise specified:  $V_s$  = 5.5 V to 40 V,  $T_j$  = -40°C to +150°C,  $R_{\text{SET}}$  = 12 kΩ, all voltages with respect to ground, positive current flowing into pin for input pins (I), positive currents flowing out of the I/O and output pins (O) (unless otherwise specified)



<span id="page-27-0"></span>1) Not subject to production test, specified by design

#### **Power Stage**



### <span id="page-28-1"></span>**11 Power Stage**

The output stage is realized as high side current source with a current of 360 mA. During off state the leakage current at the output stage is minimized in order to prevent a slightly glowing LED.

The maximum current of the channel is limited by the power dissipation and used PCB cooling areas (which results in the applications  $R_{th,10}$ ).

For an operating current control loop the supply and output voltages according to the following parameters have to be considered:

- Required supply voltage for current control  $V_{S(CC)}$ , **[Pos. 6.3.10](#page-14-3)**
- Voltage drop over output stage during current control  $V_{PS(CC)}$ , [Pos. 11.2.6](#page-29-2)
- Required output voltage for current control  $V_{\text{OUT(CC)}}$ , [Pos. 11.2.7](#page-29-3)

### <span id="page-28-2"></span>**11.1 Protection**

The device provides embedded protective functions, which are designed to prevent IC destruction under fault conditions described in this data sheet. Fault conditions are considered as "outside" normal operating range. Protective functions are neither designed for continuous nor for repetitive operation.

#### <span id="page-28-3"></span><span id="page-28-0"></span>**11.1.1 Over Load Behavior**

An over load detection circuit is integrated in the LITIX™ Basic IC. It is realized by a temperature monitoring of the output stage (OUT).

As soon as the junction temperature exceeds the current reduction temperature threshold  $T_{j(CRT)}$  the output current will be reduced by the device by reducing the IN\_SET reference voltage V<sub>IN SET(ref)</sub>. This feature avoids LED's flickering during static output overload conditions. Furthermore, it protects LEDs against over temperature, which are mounted thermally close to the device. If the device temperature still increases, the output current decreases close to 0 A. As soon as the device cools down the output current rises again.



**Figure 25 Output current reduction at high temperature**

*Note: This high temperature output current reduction is realized by reducing the IN\_SET reference voltage voltage ([Pos. 10.3.1](#page-25-2)). In case of very high power loss applied to the device and very high junction temperature the output current may drop down to*  $I_{OUT} = 0$  *mA, after a slight cooling down the current increases again.*

#### <span id="page-28-4"></span>**11.1.2 Reverse Battery Protection**

The TLD1125EL has an integrated reverse battery protection feature. This feature protects the driver IC itself, but also connected LEDs. The output reverse current is limited to *I<sub>OUTx(rev)</sub>* by the reverse battery protection.



#### **Power Stage**

*Note: Due to the reverse battery protection a reverse protection diode for the light module may be obsolete. In case of high ISO-pulse requirements and only minor protecting components like capacitors a reverse protection diode may be reasonable. The external protection circuit needs to be verified in the application.*

### <span id="page-29-4"></span>**11.2 Electrical Characteristics Power Stage**

#### **Electrical Characteristics Power Stage**

Unless otherwise specified:  $V_s$  = 5.5 V to 18 V,  $T_j$  = -40°C to +150°C,  $V_{\rm OUT}$  = 3.6 V, all voltages with respect to ground, positive current flowing into pin for input pins (I), positive currents flowing out of the I/O and output pins (O) (unle[ss otherwis](#page-6-1)e specified)

<span id="page-29-3"></span><span id="page-29-2"></span><span id="page-29-1"></span><span id="page-29-0"></span>

#### **Power Stage**

#### **Electrical Characteristics Power Stage** (cont'd)

Unless otherwise specified:  $V_S$  = 5.5 V to 18 V,  $T_j$  = -40°C to +150°C,  $V_{\rm OUT}$  = 3.6 V, all voltages with respect to ground, positive current flowing into pin for input pins (I), positive currents flowing out of the I/O and output pins (O) (unless otherwise specified)



<span id="page-30-2"></span><span id="page-30-1"></span><span id="page-30-0"></span>1) Not subject to production test, specified by design

<span id="page-30-3"></span>2) see also **[Figure 8](#page-10-0)**

<span id="page-30-4"></span>3) see also **[Figure 18](#page-20-0)**

4) see also **[Figure 6](#page-9-1)**



#### **Application Information**

### <span id="page-31-2"></span><span id="page-31-0"></span>**12 Application Information**

*Note: The following information is given as a hint for the implementation of the device only and shall not be regarded as a description or warranty of a certain functionality, condition or quality of the device.*



#### <span id="page-31-1"></span>**Figure 26 Application Diagram**

*Note: This is a very simplified example of an application circuit. In case of high ISO-pulse requirements a reverse protection diode may be used for LED protection. The function must be verified in the real application.*

### <span id="page-31-3"></span>**12.1 Further Application Information**

• For further information you may contact **<http://www.infineon.com/>**



**Package Outlines**

### <span id="page-32-0"></span>**13 Package Outlines**



**Figure 27 PG-SSOP-14** 

#### **Green Product (RoHS compliant)**

To meet the world-wide customer requirements for environmentally friendly products and to be compliant with government regulations the device is available as a green product. Green products are RoHS-Compliant (i.e Pb-free finish on leads and suitable for Pb-free soldering according to IPC/JEDEC J-STD-020).

For further information on alternative packages, please visit our website: **[http://www.infineon.com/packages](http://www.infineon.com/packages/)**.



**Revision History**

## <span id="page-33-0"></span>**14 Revision History**





# <span id="page-34-0"></span>**Table of Contents**



#### **Trademarks**

All referenced product or service names and trademarks are the property of their respective owners.

**Edition 2018-04-26 Published by Infineon Technologies AG 81726 Munich, Germany**

**© 2018 Infineon Technologies AG. All Rights Reserved.**

**Do you have a question about any aspect of this document? Email: [erratum@infineon.com](mailto:erratum@infineon.com)**

**Document reference TLD1125EL**

#### **IMPORTANT NOTICE**

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics ("Beschaffenheitsgarantie").

With respect to any examples, hints or any typical values stated herein and/or any information regarding the application of the product, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation warranties of non-infringement of intellectual property rights of any third party.

In addition, any information given in this document is subject to customer's compliance with its obligations stated in this document and any applicable legal requirements, norms and standards concerning customer's products and any use of the product of Infineon Technologies in customer's applications.

The data contained in this document is exclusively intended for technically trained staff. It is the responsibility of customer's technical departments to evaluate the suitability of the product for the intended application and the completeness of the product information given in this document with respect to such application.

For further information on technology, delivery terms and conditions and prices, please contact the nearest Infineon Technologies Office (**[www.infineon.com](http://www.infineon.com)**).

#### **WARNINGS**

Due to technical requirements products may contain dangerous substances. For information on the types in question please contact your nearest Infineon Technologies office.

Except as otherwise explicitly approved by Infineon Technologies in a written document signed by authorized representatives of Infineon Technologies, Infineon Technologies' products may not be used in any applications where a failure of the product or any consequences of the use thereof can reasonably be expected to result in personal injury.

单击下面可查看定价,库存,交付和生命周期等信息

[>>Infineon\(英飞凌\)](https://www.oneyac.com/brand/990.html)